

Application/Control No.	Applicant(s)/Patent under Reexamination
10/810,008	DURANT ET AL.
Examiner	Art Unit
Chen-Wen Jiang	3744

SEARCHED						
Class	Subclass	Date	Examiner			
62	186		`			
700	299 300					
	277 278					
361	695 688					
	687					
236	dig.9					
417	32 45					
318	471 268	2/6/2007	Cl			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
		. , , — — .			
	-				
	· · · · · · · · · · · · · · · · · · ·				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR	
EAST Searched Inventor Searched		2/6/2007	CJ	
			•	
		-		
		<u> </u>		
	-			